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Concentrator photovoltaic (CPV) solar cells and cell on carrier (CoC) assemblies - Qualification

Táto norma obsahuje anglickú verziu európskej normy.
This standard includes the English version of the European Standard.

Táto norma bola oznámená vo Vestníku ÚNMS SR č. 07/21

Obsahuje: EN IEC 62787:2021, IEC 62787:2021

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English Version

**Concentrator photovoltaic (CPV) solar cells and cell on carrier
(CoC) assemblies - Qualification
(IEC 62787:2021)**

Cellules solaires photovoltaïques à concentration (PVC) et
ensembles de cellules sur support (CoC) - Qualification
(IEC 62787:2021)

Konzentrator-Photovoltaik(CPV)- Solarzellen und -
Anordnungen von Solarzellen auf Trägern (CoC)
(IEC 62787:2021)

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European foreword

The text of document 82/1818/FDIS, future edition 1 of IEC 62787, prepared by IEC/TC 82 "Solar photovoltaic energy systems" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 62787:2021.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2021-12-10
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Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60721-2-1	2013	Classification of environmental conditions - Part 2-1: Environmental conditions appearing in nature - Temperature and humidity	EN 60721-2-1	2014
IEC 60749-3	2017	Semiconductor devices - Mechanical and climatic test methods - Part 3: External visual examination	EN 60749-3	2017
IEC 60749-6	2017	Semiconductor devices - Mechanical and climatic test methods - Part 6: Storage at high temperature	EN 60749-6	2017
IEC 60749-14	2003	Semiconductor devices - Mechanical and climatic test methods - Part 14: Robustness of terminations (lead integrity)	EN 60749-14	2003
IEC 60749-21	2011	Semiconductor devices - Mechanical and climatic test methods - Part 21: Solderability	EN 60749-21	2011
IEC 60749-22	2002	Semiconductor devices - Mechanical and climatic test methods - Part 22: Bond strength	EN 60749-22	2003
IEC 60904-1-1	2017	Photovoltaic devices - Part 1-1: Measurement of current-voltage characteristics of multi-junction photovoltaic (PV) devices	EN 60904-1-1	2017
IEC 61000-4-2	2008	Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test	EN 61000-4-2	2009

EN IEC 62787:2021 (E)

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 61193-2	2007	Quality assessment systems - Part 2: Selection and use of sampling plans for inspection of electronic components and packages	EN 61193-2	2007
IEC/TS 61836	2016	Solar photovoltaic energy systems - Terms, definitions and symbols	-	-
IEC 62108	2016	Concentrator photovoltaic (CPV) modules and assemblies - Design qualification and type approval	EN 62108	2016
IEC 62137-1-2	2007	Surface mounting technology - Environmental and endurance test methods for surface mount solder joint - Part 1-2: Shear strength test	EN 62137-1-2	2007
IEC 62670-1	2013	Photovoltaic concentrators (CPV) - Performance testing - Part 1: Standard conditions	EN 62670-1	2014
IEC/TS 62789	2014	Photovoltaic concentrator cell documentation	-	-
IEC 63202-2	-	Photovoltaic cells - Part 2: Electroluminescence image for crystalline silicon solar cells	-	-
ECSS-E-ST-20-08C Rev.1	2012	Space engineering - Photovoltaic assemblies and components - Part 7.5.8: Coating adherence (CA)	EN 16603-20-08	2014
MIL-ST-883-K	-	Test Method Standard - Microcircuits Method 2019.9 Die shear strength	-	-



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NORME INTERNATIONALE



Concentrator photovoltaic (CPV) solar cells and cell on carrier (CoC) assemblies – qualification

Cellules solaires photovoltaïques à concentration (PVC) et ensembles de cellules sur support (CoC) – Qualification





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Edition 1.0 2021-02

INTERNATIONAL STANDARD

NORME INTERNATIONALE



Concentrator photovoltaic (CPV) solar cells and cell on carrier (CoC) assemblies – qualification

Cellules solaires photovoltaïques à concentration (PVC) et ensembles de cellules sur support (CoC) – Qualification

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CONTENTS

FOREWORD	4
1 Scope	6
2 Normative references	6
3 Terms and definitions	7
4 Operating environment	9
5 Sampling	9
6 Marking	10
7 Characterization methods for measuring the performance of bare cells and CoCs subjected to qualification tests	10
7.1 General	10
7.2 Light I-V measurement	10
7.3 Dark I-V measurement	11
7.3.1 General	11
7.3.2 Procedure	11
7.4 Electroluminescence (EL) mapping	11
7.5 X-ray and Scanning Acoustic Microscope (SAM)	12
7.6 Visual inspection	12
7.7 Thermal resistance measurement	12
8 Pass criteria	13
9 Documentation and reporting	20
10 Modifications and requalification	20
11 Qualification stress tests	21
11.1 General	21
11.2 ESD damage threshold	21
11.2.1 General	21
11.2.2 Purpose	21
11.2.3 Procedure	22
11.2.4 Requirements	22
11.3 Front and back metal adhesion	22
11.3.1 Purpose	22
11.3.2 Procedure	22
11.3.3 Requirements	22
11.4 High-temperature storage	22
11.4.1 Purpose	22
11.4.2 Procedure	22
11.4.3 Requirements	23
11.5 Thermal cycling	23
11.5.1 Purpose	23
11.5.2 Procedure	23
11.5.3 Requirements	24
11.6 High temperature with current injection	24
11.6.1 Purpose	24
11.6.2 Procedure	25
11.6.3 Requirements	25
11.7 Low level light biased damp heat	25
11.7.1 Purpose	25

11.7.2 Procedure	25
11.7.3 Requirements	25
11.8 Solderability	26
11.8.1 Purpose	26
11.8.2 Procedure	26
11.8.3 Requirements	27
11.9 Illumination	27
11.9.1 Purpose	27
11.9.2 Procedure	27
11.9.3 Requirements	28
11.10 Wire/Ribbon bond strength	28
11.10.1 Purpose	28
11.10.2 Procedure	28
11.10.3 Requirements	30
11.11 Die adhesion	31
11.11.1 Purpose	31
11.11.2 Procedure	31
11.11.3 Requirements	31
11.12 Connector shear strength	32
11.12.1 Purpose	32
11.12.2 Procedure	32
11.12.3 Pass/fail criteria	33
11.13 Bypass diode shear strength	33
11.13.1 Purpose	33
11.13.2 Procedure	33
11.13.3 Requirements	33
Figure 1 – Schematics and photos of Cells on Carrier and bare cell test assembly	8
Figure 2 – Representative samples of CPV systems, where cells and CoCs are deployed	9
Figure 3 – Flow chart of qualification tests for bare solar cells	18
Figure 4 – Flow chart of qualification tests for CoCs	19
Figure 5 – Thermal Cycle Diagram for the CoC test and TCO-1	24
Figure 6 – Force diagram in the bond strength test (taken from IEC 60749-22:2002, Annex A, Method B)	29
Figure 7 – Minimum bond pull limits (normal to die) (taken from IEC 60749-22:2002, Annex A, Method B)	30
Figure 8 – Schematic of the test set up for the die adhesion test	31
Figure 9 – Die shear strength criteria (minimum force versus die attach area) (taken from MIL-ST-883-K)	32
Figure 10 – Schematics of the position of the pushing tool (taken from IEC 62137-1-2:2007)	33
Table 1 – Qualification tests description for bare solar cells	14
Table 2 – Qualification tests description for CoCs	16
Table 3 – Thermal Cycle Options (TCO) of test 11.5 for CoCs	23
Table 4 – Minimum pulling forces, PW (taken from IEC60749-22:2002, Method B)	29

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**CONCENTRATOR PHOTOVOLTAIC (CPV) SOLAR CELLS
AND CELL ON CARRIER (CoC) ASSEMBLIES –
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International Standard IEC 62787 has been prepared by subcommittee 82: Solar photovoltaic energy systems.

The text of this International Standard is based on the following documents:

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82/1818/FDIS	82/1834/RVD

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

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CONCENTRATOR PHOTOVOLTAIC (CPV) SOLAR CELLS AND CELL ON CARRIER (CoC) ASSEMBLIES – QUALIFICATION

1 Scope

This document specifies the minimum requirements for the qualification of concentrator photovoltaic (CPV) cells and Cell on Carrier (CoC) assemblies for incorporation into CPV receivers, modules and systems.

The object of this qualification standard is to determine the optoelectronic, mechanical, thermal, and processing characteristics of CPV cells and CoCs to show that they are capable of withstanding assembly processes and CPV application environments. The qualification tests of this document are designed to demonstrate that cells or CoCs are suitable for typical assembly processes, and when properly assembled, are capable of passing IEC 62108.

This document defines qualification testing for two levels of concentrator photovoltaic device assembly:

- a) cell, or bare cell; and
- b) cell on carrier (CoC).

NOTE Note that a variety of alternate names are used within the industry, such as solar cell assembly, receiver, etc.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60721-2-1:2013, *Classification of environmental conditions – Part 2-1: Environmental conditions appearing in nature – Temperature and humidity*

IEC 60749-3:2017, *Semiconductor devices – Mechanical and climatic test methods – Part 3: External visual examination*

IEC 60749-6:2017, *Semiconductor devices – Mechanical and climatic test methods – Part 6: Storage at high temperature*

IEC 60749-14:2003, *Semiconductor devices – Mechanical and climatic test methods – Part 14: Robustness of terminations (lead integrity)*

IEC 60749-21:2011, *Semiconductor devices – Mechanical and climatic test methods – Part 21: Solderability*

IEC 60749-22:2002, *Semiconductor devices – Mechanical and climatic test methods – Part 22: Bond strength*

IEC 60904-1-1:2017, *Photovoltaic devices – Part 1-1: Measurement of current-voltage characteristics of multi-junction photovoltaic (PV) devices*

IEC 61000-4-2:2008, *Electromagnetic compatibility (EMC) – Part 4-2: Testing and measurement techniques – Electrostatic discharge immunity test*

IEC 61193-2:2007, *Quality assessment systems – Part 2 selection and use of sampling plans for inspection of electronic components and packages*

IEC TS 61836:2016, *Solar photovoltaic energy systems – Terms, definitions and symbols*

IEC 62108:2016, *Concentrator photovoltaic (CPV) modules and assemblies – Design qualification and type approval*

IEC 62137-1-2:2007, *Surface mounting technology – Environmental and endurance test methods for surface mount solder joint – Part 1-2: Shear strength test*

IEC 62670-1:2013, *Photovoltaic concentrators (CPV) – Performance testing – Part 1: Standard conditions*

IEC TS 62789:2014, *Photovoltaic concentrator cell documentation*

IEC 63202-2, *Photovoltaic cells – Part 2: Electroluminescence image for crystalline silicon solar cells*

ECSS-E-ST-20-08C Rev 1, 18 July 2012, *Space engineering – Photovoltaic assemblies and components – Part 7.5.8: Coating adherence (CA)*

MIL-ST-883-K, *Test Method Standard – Microcircuits Method 2019.9 Die shear strength*

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